

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant(s): Michael REINSTADTLER et al  
Serial No.: 10/524,729  
Filed: February 16, 2005  
For: METHOD FOR DETERMINING TRIBOLOGICAL  
PROPERTIES OF A SAMPLE SURFACE  
USING AN ATOMIC FORCE SCANNING  
MICROSCOPE AND AN ATOMIC FORCE  
SCANNING MICROSCOPE THEREFORE  
Art Unit: 2856  
Examiner: Daniel Sean LARKIN

**AMENDMENT**

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

September 27, 2007

Sir:

This is in response to the first Office Action of June 29, 2007. Please amend the above-identified application as listed below and as set forth on the following pages:

Amendments to the Specification and Abstract

Amendments to the Claims

Amendments to the Drawings describing changes to drawings shown in the Appendix

Remarks are included following the amendments

An Appendix including amended drawing figures is attached following the Remarks

Supplemental Declaration